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AD-A200 887

EPORT DOCUMENTATION PAGE						
Ta REPORT SECURITY CLASSIFICATION	16 RESTRICTIVE MARKINGS					
Unclassified						
28 SECURITY CLASSIFICATION AUTHORITY		3 DISTRIBUTION AVAILABILITY OF REPORT				
26 DECLASSIFICATION / DOWNGRADING SCHEDULE		Approved for public release; distribution unlimited.				
4 PERFORMING ORGANIZATION REPORT NUMBER	(S)	5 MONITORING ORGANIZATION REPORT NUMBER(S)				
Technical Report No. Du/DC/TR-10		STICL				
	66 OFFICE SYMBOL	7a NAME OF MO	NITORING ORGANI	ZATION	JICTET	
Department of Chemistry	(If applicable)	Office of Naval Research			ELEC	
Duke University						
6c ADDRESS (City, State, and ZIP Code)	7b ADDRESS (City, State and ZIP Code)					
Durham, NC 27706	800 N. Quincy Street Arlington, VA 22217-5000					
88 NAME OF FUNDING SPONSORING	86 OFFICE SYMBOL	9 PROCUREMENT	INSTRUMENT IDET	NTIFICATION N	IUMBER	
ORGANIZATION	(if applicable)					
Office of Naval Research		N00014-83-	K-0572; R&T	<u>Code 4135</u>	00803	
8c ADDRESS (City, State, and ZIP Code)			UNDING NUMBERS			
800 N. Quincy Street		PROGRAM ELEMENT NO	PROJECT NO	TASK NO	WORK JNT ACCESSION NO	
Arlington, VA 22217-5000						
11 TITLE (Include Security Classification)		NR	053	841		
The Use of Tris(trimethylsilyl)arsine to Prepare Gallium Arsenide and Indium Arsenide						
12 PERSONAL AUTHOR(S) R.L. Wells, C.G. Pitt, A.T.	McPhail, A.P. I	Purdy, S. Sh	afieezad, and	l R.B. Hal	llock	
13a TYPE OF REPORT 13b TIME COVERED 14 DATE OF REPORT (Year, Month, Day) 15 PAGE COUNT Technical FROMTO 88-10-03 10						
16 SUPPLEMENTARY NOTATION Accepted for publication in Chemistry of Materials						
17 COSATI CODES	18 SUBJECT TERMS (C	ontinue on reverse	e if necessary and	identify by bl	lock number)	
FIELD GROUP SUB-GROUP	Gallium Arse	enide, Indium Arsenide, Preparation				
	001110 1115	enide, indiam Arsenide, irreparation				
			1000			
19 ABSTRACT (Continue on reverse if necessary a	* *					
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20 DISTRIBUTION / AVAILABILITY OF ABSTRACT	21 ABSTRACT SECURITY CLASSIFICATION					
■ UNCLASSIFIED/UNLIMITED ■ SAME AS RE	Unclassified					
■ UNCLASSIFIED/UNLIMITED □ SAME AS RPT □ DTIC USERS 22a NAME OF RESPONSIBLE INDIVIDUAL		226 TELEPHONE	Include Area Code)	22c OFFICE	SYMBOL	
Richard L. Wells		(919)684	-6404	1		

OFFICE OF NAVAL RESEARCH

Contract NOO014-83-K-0572

R&T Code 4135008---03

Technical Report No. DU/DC/TR-10

The Use of Tris(trimethylsilyl)arsine to Prepare

Gallium Arsenide and Indium Arsenide

by

R. L. Wells, C. G. Pitt, A. T. McPhail, A. P. Purdy, S. Shafieezad, and R. B. Hallock

Prepared for Publication in Chemistry of Materials

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October 3, 1988

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[Communication]

The Use of Tris(trimethylsilyl)arsine to Prepare Gallium Arsenide and Indium Arsenide

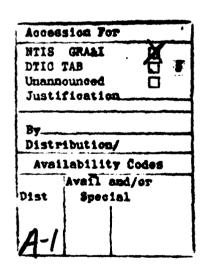
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Received July 29, 1988; Received in revised form

, 1988





Sir:

One of the processes commonly used for the epitaxial growth of GaAs and other compound semiconductors is organometallic chemical vapor deposition (OMCVD). For GaAs, it has been the general practice to utilize a trialkylgallium compound and AsH₃ in this process, as exemplified by equation 1. However, concerns regarding

the use of AsH₃ have prompted a number of researchers to evaluate other sources of arsenic; thus, replacements for AsH₃ which have been studied include As, Me₃As, Et₃As, Et₂AsH, and t-BuAsH₂.²

Alternatively, some adducts of gallium and arsenic compounds,³⁻⁵ as well as a monomeric and a dimeric mono(arsino)gallane,^{6,7} have been used as single source GaAs precursors.

Recent research in our laboratories has demonstrated that dehalosilyation reactions (e.g., equation 2) are a facile route to the

$$R_2 AsSiMe_3 + GaX_3 \longrightarrow 1/3 (R_2 AsGaX_2)_3 + Me_3 SiX$$

$$R = Me_3 SiCH_2; X = Cl \text{ or } Br$$
(2)

formation of the Ga-As covalent bond and, as a result, we have prepared and characterized a number of new Ga-As compounds.⁸⁻¹¹ We now report the first examples of the use of dehalosilylation reactions to prepare GaAs and InAs. Reactions between (Me₃Si)₃As and MX₃ (M=Ga, X=Cl or Br; M=In, X=Cl) proceed at relatively low

temperatures to eliminate Me₃SiX with the concurrent formation of GaAs and InAs, respectively (equation 3).

$$(Me_3Si)_3As + MX_3 \longrightarrow MAs + 3Me_3SiX$$
 (3)
 $(M=Ga, X=Cl \text{ or } Br; M=In, X=Cl)$

Tris(trimethylsilyl)arsine¹² (0.343g, 1.16 mmol) was added to a solution of GaCl₃ (0.205 g, 1.16 mmol) in 25 mL of ligroin (bp 90-110 °C) at room temperature. 13 Upon mixing, a white precipitate formed which quickly changed color to yellow then to orange. After stirring for 3 days at 75 °C, the volatiles were distilled off and shown to contain 2.89 mmol of Me₃SiCl.¹⁴ The remaining brown solid was heated in the absence of solvent using a heating mantle while the reaction bulb was opened to a -196 °C trap on the vacuum line. As the temperature was increased to 85 °C, a small amount of colorless material began to collect in the trap. The bulb was further heated at 125 °C for 30 min, then the temperature was increased to 185 °C for 2 h. At this time it did not appear that any more material was collecting in the trap. The solid in the flask was dark brown to black. The colorless liquid was distilled from the trap and shown to contain 0.39 mmol of Me₃SiCl (total Me₃SiCl = 3.28 mmol, 94% theoretical). Further heating of the solid product to 380 °C for 90 min resulted in a trace of yellow liquid collecting in the trap beginning at 330 °C. The resulting black solid (0.136 g, 81% yield) was poured out of the bulb through the valve stem. It was shown to be GaAs of about 95% purity by partial elemental analysis¹⁵ and comparison of its X-ray

powder diffraction pattern with that for a bona fide sample of GaAs. In a separate experiment, GaCl₃ (0.411 g, 2.33 mmol) and (Me₃Si)₃As (0.688 g, 2.33 mmol) were combined in pentane (30 mL). A precipitate formed as in the first experiment. The mixture was stirred overnight at room temperature and the precipitate appeared light brown. Removal of volatiles showed that 4.47 mmol of Me₃SiCl had formed. Toluene (30 mL) was distilled onto the brown solid and the slurry was stirred overnight at 90 °C, causing the formation of an additional 1.42 mmol of Me₃SiCl. The resulting solid was heated in the absence of solvent overnight at 140-160 °C, then for 3 h at 160-180 °C. An additional 0.60 mmol of Me₃SiCl was formed (total Me₃SiCl = 6.49 mmol, 93% theoretical). The bulb containing the solid was heated with a cool flame (propane, no oxygen; ~400-500 °C) for 2 h and a trace of yellow liquid collected in the trap. The resulting black solid (0.294 g, 87% yield) was shown to be GaAs of about 96% purity by complete elemental analysis¹⁶ and comparison of its X-ray powder diffraction pattern with that for a bona fide sample of GaAs.

The reaction between (Me₃Si)₃As and GaBr₃ did not proceed as readily as the corresponding reaction with GaCl₃. Stirring an equimolar mixture of (Me₃Si)₃As and GaBr₃ (1.19 mmol) overnight in benzene at 47 °C resulted in the elimination of 1.39 mmol of Me₃SiBr; an additional 1.16 mmol of Me₃SiBr was eliminated after heating overnight at 75-85 °C. Further heating of the resultant reddish-brown solid in the absence of solvent to 410 °C did not result in the clean elimination of additional Me₃SiBr, rather the formation of an unidentified slightly volatile yellow liquid was observed. The nonvolatile black solid was shown to be GaAs of 88% purity by

partial elemental analysis¹⁷ and comparison of its X-ray powder diffraction pattern with that for a bona fide sample of GaAs. The ¹H NMR spectrum of the yellow liquid consists of broad peaks near 1 ppm.

The reaction of (Me₃Si)₃As with InCl₃ proceeded in a manner similar to the analogous reactions with gallium halides. InCl₃ (0.314 g, 1.42 mmol) and (Me₃Si)₃As (0.415 g, 1.41 mmol) were combined in 35 mL pentane. A salmon colored precipitate formed immediately upon mixing and rapidly changed color to dark brown. The mixture was stirred at room temperature for 3 days and 2.33 mmol of Me₃SiCl were evolved. Further heating in benzene at 70-75 °C for 4 days resulted in the formation of an additional 0.99 mmol of Me₃SiCl. Heating of the remaining brown solid in the solid state overnight at 150 °C caused the elimination of 0.32 mmol additional Me₃SiCl. Finally, the solid was heated for 15 min with a cool flame and a trace (0.05 mmol) of Me₃SiCl collected in the trap (total Me₃SiCl = 3.69 mmol, 87% yield). The resulting fluffy black solid (0.153 g, 57% yield) was shown to be InAs of 98% purity by complete elemental analysis 18 and comparison of its X-ray powder diffraction pattern with that for a bona fida sample of InAs.

This work demonstrates that dehalosilylation reactions provide a viable route to the formation of GaAs and InAs. These two compound semiconductors were isolated in 88-96% and 98% purity, respectively, from very crude experiments with no attempts to optimize the reaction conditions. The formation of GaAs and InAs with low incorporation of Si relative to C and to halogen in these experiments is of interest. This may be due to the decomposition of

the Me₃Si group to form polysilanes at elevated temperatures. During the thermal decomposition of (Me₃Si)₃Al polysilanes have been observed; ¹⁹ similar decomposition of the Me₃Si group may occur at high temperatures in our system. In contrast, the pyrolysis of [(Me₃Si)₂AlNH₂]₂ gave a solid solution of AlN and SiC.²⁰

Tris(trimethylsilyl)arsine is a liquid with a relatively low vapor pressure (bp 50-52 °C at 10-3 mm)¹² and may prove useful as a safer alternative to AsH₃ gas in the vapor deposition of GaAs and other As containing alloys. Gallium trichloride has an appreciable vapor pressure at room temperature and has been applied to CVD growth of GaAs in other systems.²¹ The extension of these prelimary results to vapor phase epitaxy is worth investigating as an alternative to typical OMCVD processes.

Acknowledgement. This work was supported in part by the Office of Naval Research.

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- 13. All manipulations were carried out on a vacuum line or in a nitrogen filled glove box. (Me₃Si)₃As is an air sensitive liquid which has a very disagreeable odor and was handled with the assumption that it has some toxicity.
- 14. The quantities of Me₃SiCl or Me₃SiBr formed in the reactions were determined as HCl or HBr by vacuum distillation of all volatiles from the reaction mixture followed by hydrolysis and titration with standard NaOH solution.
- 15. Anal. Calcd (Found) for GaAs: C, 0.00 (1.35); H, 0.00 (0.98); Cl, 0.00 (2.36); Si, 0.00 (0.45).
- 16. Anal. Calcd (Found) for GaAs: C, 0.00 (1.68); H, 0.00 (0.30); As, 51.80 (50.08); Cl, 0.00 (2.51); Ga, 48.21 (45.96); Si, 0.00 (0.51); (Ga:As mol ratio=1.00:1.01).

- 17. Anal. Calcd (Found) for GaAs: C, 0.00 (3.58); H, 0.00 (0.19); Br, 0.00 (7.21); Si, 0.00 (<0.7).
- 18. Anal. Calcd (Found) for InAs: C, 0.00 (0.56); H, 0.00 (0.17); As, 39.49 (38.32); Cl, 0.00 (0.80); In, 60.51 (59.21); Si 0.00 (<0.1); (In:As mol ratio=1.00:0.99). The low yield of both InAs and Me₃SiCl obtained in this experiment may be due to the fact that a significant amount of material adhered to the walls of the reaction bulb and was not isolated.
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(Abstract for use by Chemical Abstracts)

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Gallium Arsenide and Indium Arsenide

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DL/1113/87/2

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